

Description.

The present invention relates to an electroless copper plating solution capable of forming a deposited film with high elongation.

5 In the manufacture of printed wiring boards, an electroless copper plating solution is used for forming conductors on insulating substrates. Currently, the following two processes are mainly employed for forming conductors on insulating substrates by using an electroless copper plating solution.

One process (called "full additive process") comprises coating a plating resist on non-conductor areas of an insulating substrate and then dipping the insulating substrate in an electroless copper plating solution to form conductors of an electroless plated copper film on the areas of the insulating substrate not coated with the plating resist. Another process (called "semi-additive process") comprises immersing an insulating substrate in an electroless copper plating solution to form a thin electroless copper deposited film on the entire surface of the insulating substrate, then coating a plating resist on non-conductor areas of the substrate, conducting electroplating of copper to form an electroplated copper film on the resistless areas, and then removing the plating resist, removing the thin electroless plated copper film at the area having no electroplated copper film by means of quick etching to thereby form the desired conductors on the insulating substrate.

Electroless copper plating solutions generally comprise a cupric salt such as cupric sulfate, an alkali-soluble complexing agent for cupric ions such as ethylenediaminetetracetic acid, a reducing agent such as formaldehyde and a pH adjuster which is an alkali hydroxide. The deposited films obtained by using known plating solutions are usually brittle. If the deposited film is brittle and low in elongation in the case of a printed wiring board, conductors easily break at corner portions of through-holes (the circumferential angular portions of the through-holes) due to expansion and shrinkage of the substrate depending on temperature changes.

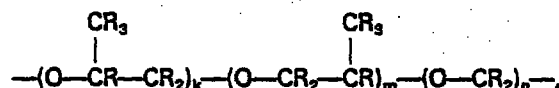
15 In order to overcome this problem, it has been proposed to add certain specific compounds such as a cyanide, α, α' -dipyridyl, a 1,10-phenanthroline, polyalkylene oxide, polyethylene glycol and the like to a plating solution. For instance, U.S. Patent No. 3,095,309 proposes the addition of a cyanide and U.S. Patent No. 3,607,317 proposes the combined use of a cyanide and a polyalkylene oxide. Also, in U.S. Patent No. 4,099,974 is proposed the addition of 2,2'-dipyridyl or 2,9-dimethyl-1,10-phenanthroline, and a polyethylene glycol. However, any of these proposals are insufficient for the improvement in elongation of the deposited film although gloss is provided on the film.

DE-A-2632920 describes electroless copper plating solutions containing fluoropolyethers.

An object of this invention is to provide an electroless copper plating solution capable of forming a deposited film with high elongation.

35 The present invention provides an electroless copper plating solution comprising:

- (a) cupric ions, a complexing agent for cupric ions, a reducing agent and a pH adjuster;
- (b) a fluoropolyether comprising linear chains of the formula:



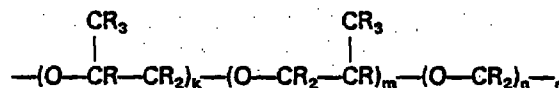
or



wherein each R is fluorine, a part of which may be substituted with hydrogen and/or chlorine; k and m are each zero or a positive number (but k and m cannot be zero at the same time); and n, p and q are each a positive number; and

50 (c) at least one member selected from a cyanide, α, α' -dipyridyl, or 1,10-phenanthroline or a derivative thereof, the plating solution having an alkaline pH, the concentration of cyanide being from 2 to 200 mg/l or the concentration of α, α' -dipyridyl, 1,10-phenanthroline or a derivative thereof being at least 5 mg/l.

The fluoropolyether used in the present invention has a backbone represented by the general formula:



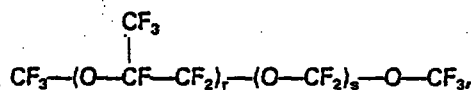
or



wherein each R is fluorine, a part of which may be substituted with hydrogen and/or chlorine; k and m are each zero or a positive number (but k and m cannot be zero at the same time); and n, p and q are each a positive number.

The fluoropolyether used in this invention preferably has a molecular weight (a number average molecular weight) in the range of 500 to 50,000.

It is desirable in this invention to use at least one of those fluoropolyethers which are represented by the general formula:



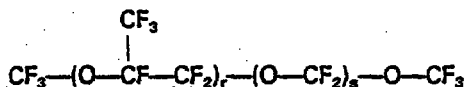
10 or



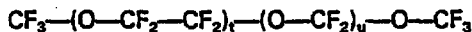
wherein r, s, t and u are each a positive number.

15 Such fluoropolyethers are commercially available, such as Fomblin Y® and Fomblin Z® manufactured by Montefluos S.p.A. (Italy).

Fomblin Y has the following chemical structure:



Fomblin Z has the following chemical structure:



These commercial fluoropolyethers range in number average molecular weight from about 1,000 to 20,000, and any of these commercial products can be used in this invention.

30 The solubility of fluoropolyethers in the plating solution is very low. In this invention, it suffices to add a fluoropolyether in a small effective amount, for example 0.01 mg/l or greater, preferably not exceeding 50 mg/l. Excess addition gives no adverse effect to the elongation of the copper deposit. When this compound is added in an excess amount, it merely undergoes a phase separation from the plating solution and is dispersed in the manner of oil. Thus, when the compound is added in an excess amount, the concentration in the plating solution is self controlled by the solubility of the compound. Two or more different types of fluoropolyether can be used in admixture. A part of the fluorine atoms in the fluoropolyether may be substituted with one or more hydrogen and/or chlorine atoms.

As the cyanide, there can be used metal cyanides such as sodium cyanide (NaCN), potassium cyanide (KCN), nickel cyanide (NiCN), cobalt cyanide (Co(CN)₂), etc.; cyano-complex compounds such as sodium ferrocyanide (Na₄(Fe(CN)₆)), potassium ferrocyanide (K₄(Fe(CN)₆)), sodium ferricyanide (Na₃(Fe(CN)₆)), 40 potassium ferricyanide (K₃(Fe(CN)₆)), sodium nitroprusside (Na₂Fe(CN)₅(NO)), etc.; and organic cyanides such as glycolonitrile (HOCH₂CN), aminoacetonitrile (NH₂CH₂CN), etc. The concentration of the cyanide is in the range of 2 to 200 mg/l. When the cyanide concentration is less than 2 mg/l or exceeds 200 mg/l, no deposited film with a satisfactorily high elongation can be obtained. The more preferred range of cyanide concentration is 5 to 80 mg/l and the most preferred range is 10 to 50 mg/l.

45 The concentration of α,α'-dipyridyl is at least 5 mg/l and preferably not more than 300 mg/l. When it is below 5 mg/l, there can be obtained no deposited film with a satisfactorily high elongation, and when said concentration exceeds 300 mg/l, the depositing rate is reduced. The α,α'-dipyridyl concentration is more preferably 10 to 150 mg/l and most preferably 15 to 60 mg/l.

As 1,10-phenanthroline or derivatives thereof, there can be used, for example, 1,10-phenanthroline, 50 4,7-diphenyl-1,10-phenanthroline and 2,9-dimethyl-1,10-phenanthroline. The concentration of such 1,10-phenanthrolines is at least 5 mg/l and preferably not more than 300 mg/l. If the concentration is less than 5 mg/l, it is impossible to obtain a deposited film with a sufficiently high elongation, and if said concentration exceeds 300 mg/l, the depositing rate is reduced. The more preferred range of 1,10 phenanthroline concentration is 10 to 150 mg/l and the most preferred range is 15 to 60 mg/l.

55 The cupric ions are supplied by an organic or inorganic cupric salt such as cupric sulfate, cupric nitrate, cupric chloride, cupric bromide, cupric acetate and the like. Such cupric ions preferably exist in a concentration of 0.004 to 0.2 mol/l.

60 The complexing agent for these cupric ions is a compound which forms with cupric ions a complex soluble in aqueous alkali solutions. Typical examples of such a complexing agent are ethylenediamine-tetraacetic acid and its sodium salt, Rochelle salts, N,N,N',N'-tetrakis-(2-hydroxypropyl)-ethylenediamine, triethanolamine, ethylenenitrilotetraethanol and the like. The preferred concentration of the complexing agent in the plating solution is 0.004 to 1 mol/l.

As the reducing agent, formaldehyde or paraformaldehyde can be used in an amount of preferably 0.01 to 0.25 mol/l.

65 As the pH adjuster, alkali hydroxides such as sodium hydroxide, potassium hydroxide and the like can

be used. Such pH adjuster is preferably used in an amount necessary for adjusting the pH of the solution to 11.0 to 13.5. (12)

The fundamental composition of the electroless copper plating solution of this invention preferably comprises 5 to 15 g/l of cupric sulfate, 15 to 60 g/l of ethylenediaminetetraacetic acid as a complexing agent and 2 to 20 ml/l of a 37% aqueous formaldehyde solution as a reducing agent, and it is preferred that the solution be adjusted to a pH of 11.6 to 13.0 and used at a temperature of 60 to 80°C.

As described above, the electroless plating solution of this invention is capable of providing a deposited film with a high elongation and can be advantageously used for forming circuits on a substrate in the manufacture of printed wiring boards according principally to the full additive or semi-additive process.

Examples 1—8 and Comparative Examples 1—5

Stainless steel plates having smooth polished surfaces had their surfaces degreased and applied with Pd serving as a reaction initiator (catalyst) and then were subjected to electroless copper plating at 70°C by using the plating solutions having the compositions shown in Table 1 to obtain the deposited copper films.

The deposited films formed on said stainless steel plates were peeled off from the substrate surfaces and cut to pieces measuring 10 mm width and 80 mm long, and their film properties were measured by using a tensile tester (Tension/UTM-1—5000 BW, manufactured by Toyo Baldwin Co., Ltd. (Japan)) at a crosshead speed of 1 mm/min and a gauge length of 15 mm. The results are shown in Table 2.

TABLE 1

			Example								Comparative Example					
			1	2	3	4	5	6	7	8	1	2	3	4	5	6
CuSO ₄ · 5H ₂ O (g/l)			10	10	10	10	7	7	7	7	10	10	10	10	10	10
EDTA* (g/l)			30	30	30	30	30	30	30	30	20	30	30	30	30	30
HCHO 37% aqueous solution (ml/l)			3.5	3.5	3.5	3.5	3.5	3.5	3.5	3.5	3.5	3.5	3.5	3.5	3.5	3.5
Fluoro-polyether (g/l)	Fomblin Y	MW** 1500	0.1	—	—	—	—	—	—	—	0.1	—	—	—	—	—
		MW 3000	—	—	0.1	—	—	0.1	—	—	—	—	—	—	—	—
		MW 6500	—	0.1	—	0.1	—	—	0.1	0.1	—	0.1	—	—	—	—
	Fomblin Z	MW 14500	—	—	—	—	0.1	—	—	—	—	—	0.1	—	—	—
NaCN (ml/l)			—	—	—	—	—	—	40	—	—	—	—	—	40	—
Sodium ferrocyanide (ml/l)			30	40	—	—	—	—	—	10	—	—	—	—	—	—
α,α'-Dipyridyl (ml/l)			—	—	50	25	30	—	—	40	—	—	—	30	—	—
1,10-Phenanthroline (ml/l)			—	—	—	—	—	30	—	—	—	—	—	—	—	—
pH***			12.0	12.0	12.5	12.5	12.3	12.5	12.0	12.0	12.3	12.3	12.3	12.3	12.3	12.0

Notes:

*EDTA: ethylenediaminetetraacetic acid.

**MW: number average molecular weight.

***pH: at solution temperature of 20°C (pH adjuster: NaOH).

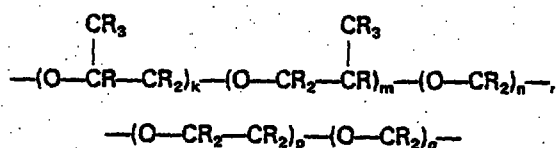
TABLE 2

		Elongation of deposited film (%)	Tensile strength of deposited film (kg/mm ²)	Depositing rate (μm/hr)	Deposited film thickness (μm)	Glossy
Example	1	12.5	33.5	2.8	29.5	Yes
	2	11.5	30.0	2.4	25.4	Yes
	3	10.1	37.7	2.6	25.2	Yes
	4	11.7	34.5	2.7	27.1	Yes
	5	11.8	33.2	2.4	26.3	Yes
	6	9.6	32.1	2.5	28.1	Yes
	7	9.4	34.3	2.7	26.1	Yes
	8	11.6	32.7	2.3	26.5	Yes
Comparative Example	1	4.8	35.4	2.6	25.9	No
	2	5.4	36.1	2.4	27.3	No
	3	5.2	33.6	2.5	28.2	No
	4	4.1	33.2	3.8	26.5	Yes
	5	4.3	32.7	2.6	27.4	Yes
	6	2.9	35.0	3.6	28.5	No

Claims

1. An electroless copper plating solution comprising:

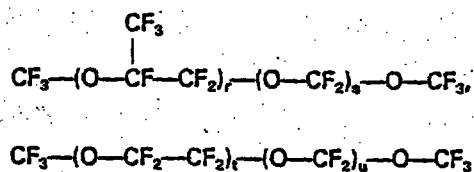
- (a) cupric ions, a complexing agent for cupric ions, a reducing agent and a pH adjuster;
 (b) a fluoropolyether comprising linear chains of the formula:



wherein each R is fluorine, a part of which may be substituted with hydrogen and/or chlorine; k and m are each zero or a positive number provided that k and m are not both zero; and n, p and q are each a positive number; and

(c) at least one compound which is a cyanide or α,α'-dipyridyl or 1,10-phenanthroline or a derivative thereof, the plating solution having an alkaline pH, the concentration of cyanide being from 2 to 200 mg/l or the concentration of α,α'-dipyridyl, 1,10-phenanthroline or a derivative thereof being at least 5 mg/l.

2. An electroless copper plating solution according to Claim 1, wherein the fluoropolyether is at least one of the fluoropolyethers of the formula:



wherein r, s, t and u are each a positive number.



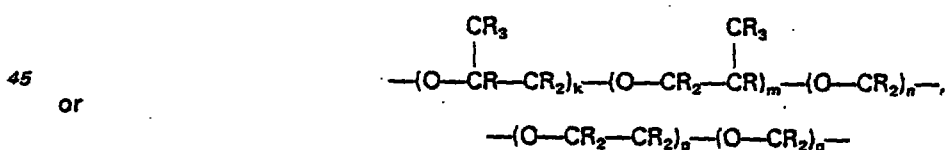
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	3	10.1	37.7	2.6	25.2	Yes
	4	11.7	34.5	2.7	27.1	Yes
	5	11.8	33.2	2.4	26.3	Yes
	6	9.6	32.1	2.5	28.1	Yes
	7	9.4	34.3	2.7	26.1	Yes
	8	11.6	32.7	2.3	26.5	Yes
Comparative Example	1	4.8	35.4	2.6	25.9	No
	2	5.4	36.1	2.4	27.3	No
	3	5.2	33.6	2.5	28.2	No
	4	4.1	33.2	3.8	26.5	Yes
	5	4.3	32.7	2.6	27.4	Yes
	6	2.9	35.0	3.6	28.5	No

Claims

1. An electroless copper plating solution comprising:

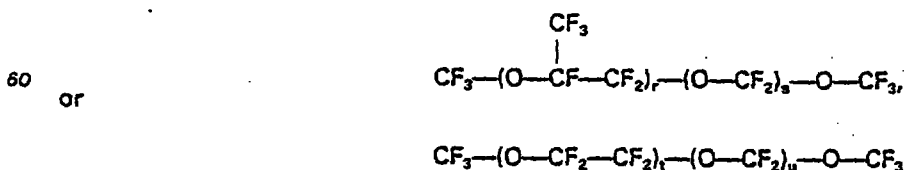
- (a) cupric ions, a complexing agent for cupric ions, a reducing agent and a pH adjuster;
(b) a fluoropolyether comprising linear chains of the formula:



wherein each R is fluorine, a part of which may be substituted with hydrogen and/or chlorine; k and m are each zero or a positive number provided that k and m are not both zero; and n, p and q are each a positive number; and

(c) at least one compound which is a cyanide or α,α'-dipyridyl or 1,10-phenanthroline or a derivative thereof, the plating solution having an alkaline pH, the concentration of cyanide being from 2 to 200 mg/l or the concentration of α,α'-dipyridyl, 1,10-phenanthroline or a derivative thereof being at least 5 mg/l.

2. An electroless copper plating solution according to Claim 1, wherein the fluoropolyether is at least one of the fluoropolyethers of the formula:



wherein r, s, t and u are each a positive number.



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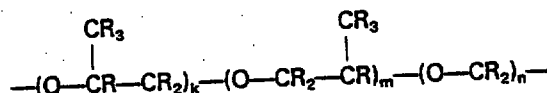
(14)

3. An electroless copper plating solution according to Claim 1 or 2, wherein the fluoropolyether is used in an amount of 50 mg/l or less.

4. An electroless copper plating solution according to any one of the preceding claims, wherein the fluoropolyether has a number average molecular weight of 1,000 to 20,000.

Patentansprüche

1. Bad für die stromlose Abscheidung von Kupfer, dadurch gekennzeichnet, daß es
- (a) Kupfer(II)ionen, einen Komplexbildner für Kupfer(II)ionen, ein Reduktionsmittel und ein pH-Einstellungsmittel,
- (b) einen Fluorpolyether, enthaltend lineare Ketten der Formel:



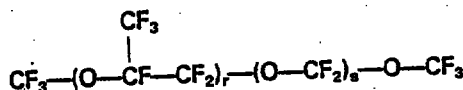
oder



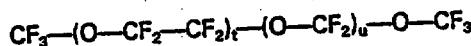
worin jedes R für Fluor steht, wobei ein Teil davon durch Wasserstoff und/oder Chlor substituiert sein kann, k und m jeweils Null oder eine positive Zahl sind, mit der Maßgabe, daß k und m nicht beide Null sind, und n, p und q jeweils eine positive Zahl sind und

- (c) mindestens eine Verbindung, nämlich ein Cyanid oder α, α' -Dipyridyl oder 1,10-Phenanthrolin oder ein Derivat davon enthält, wobei das Bad einen Alkalischen pH-Wert aufweist, die Konzentration des Cyanids 2 bis 200 mg/l beträgt oder die Konzentration des α, α' -Dipyridyls, 1,10-Phenanthrolins oder eines Derivats davon mindestens 5 mg/l beträgt.

2. Bad für die stromlose Abscheidung von Kupfer nach Anspruch 1, dadurch gekennzeichnet, daß der Fluorpolyether mindestens einer der Fluorpolyether der Formel:



oder



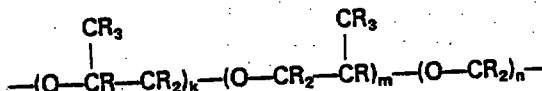
- worin r, s, t und u jeweils eine positive Zahl sind, ist.
3. Bad für die stromlose Abscheidung von Kupfer nach Anspruch 1 oder 2, dadurch gekennzeichnet, daß der Fluorpolyether in einer Menge von 50 mg/l oder weniger verwendet wird.

4. Bad für die stromlose Abscheidung von Kupfer nach einem der vorstehenden Ansprüche, dadurch gekennzeichnet, daß der Fluorpolyether ein zahlenmittleres Molekulargewicht von 1.000 bis 20.000 hat.

Revendications

1. Solution pour dépôt chimique de cuivre, comprenant:

- (a) des ions cuivriques, un agent complexant pour ions cuivriques, un agent réducteur et un ajusteur de pH;
- (b) un fluoropolyéther comprenant des chaînes linéaires de formule:



ou



- où chaque R représente un atome de fluor, une partie d'entre eux pouvant être remplacée par de l'hydrogène et/ou du chlore; k et m représentent chacun zéro ou un nombre positif, à condition que k et m ne soient pas tous deux égaux à zéro; et n, p et q représentent chacun un nombre positif; et

- (c) au moins un composé qui est un cyanure ou le α, α' -dipyridyle ou la 1,10-phénantroline ou un de leurs dérivés, la solution de dépôt ayant un pH alcalin, la concentration en cyanure étant de 2 à 200 mg/l, ou

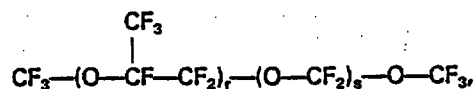


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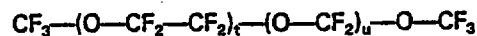
la concentration en α, α' -dipyridyle, en 1,10-phénantroline ou en un de leurs dérivés étant d'au moins 5 mg/l.

2. Solution pour dépôt chimique de cuivre selon la revendication 1; dans laquelle le fluoropolyéther est au moins un des fluoropolyéthers de formule:

5



10 ou



où r, s, t et u représentent chacun un nombre positif.

15 3. Solution pour dépôt chimique de cuivre selon la revendication 1 ou 2, dans laquelle le fluoropolyéther est utilisé à raison de 50 mg/l ou moins.

4. Solution pour dépôt chimique de cuivre selon l'une quelconque des revendications précédentes, dans laquelle le fluoropolyéther présente un poids moléculaire moyen de 1000 à 20.000.

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